HGTD10N40F1, HGTD10N40F1S, HGTD10N50F1, HGTD10N50F1S

March 1997

10A, 400V and 500V N-Channel IGBTs

Features

- 10A, 400V and 500V
- $V_{CE(ON)}$ 2.5V Max.
- T_{FALL} $\leq$1.4μs
- Low On-State Voltage
- Fast Switching Speeds
- High Input Impedance

Applications

- Power Supplies
- Motor Drives
- Protective Circuits

Description

The HGTD10N40F1, HGTD10N40F1S, HGTD10N50F1, and HGTD10N50F1S are n-channel enhancement-mode insulated gate bipolar transistors (IGBTs) designed for high voltage, low on-dissipation applications such as switching regulators and motor drivers. These types can be operated directly from low power integrated circuits.

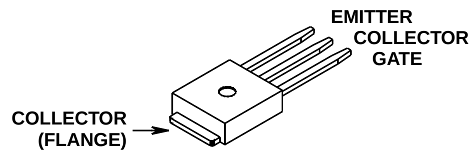
PACKAGING AVAILABILITY

PART NUMBER	PACKAGE	BRAND
HGTD10N40F1	TO-251AA	G10N40
HGTD10N50F1	TO-251AA	G10N50
HGTD10N40F1S	TO-252AA	G10N40
HGTD10N50F1S	TO-252AA	G10N50

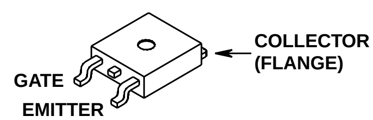
NOTE: When ordering, use the entire part number. Add the suffix 9A to obtain the TO-252AA variant in the tape and reel, i.e., HGTD10N40F19A.

Packages

HGTD10N40F1, HGTD10N50F1
JEDEC TO-251AA

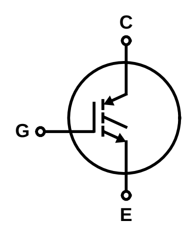


HGTD10N40F1S, HGTD10N50F1S
JEDEC TO-252AA



Terminal Diagram

N-CHANNEL ENHANCEMENT MODE



Absolute Maximum Ratings $T_C = +25^oC$, Unless Otherwise Specified

		HGTD10N40F1 HGTD10N40F1S	HGTD10N50F1 HGTD10N50F1S	UNITS
Collector-Emitter Voltage	V_{CES}	400	500	V
Collector-Gate Voltage R_{GE} = 1MΩ	V_{CGR}	400	500	V
Gate-Emitter Voltage	V_{GE}	±20	±20	V
Collector Current Continuous at $T_C = +25^oC$	I_{C25}	12	12	A
at $T_C = +90^oC$	I_{C90}	10	10	A
Power Dissipation Total at $T_C = +25^oC$	P_D	75	75	W
Power Dissipation Derating $T_C > +25^oC$		0.6	0.6	$W/^oC$
Operating and Storage Junction Temperature Range	T_J, T_{STG}	-55 to +150	-55 to +150	^oC

INTERSIL CORPORATION IGBT PRODUCT IS COVERED BY ONE OR MORE OF THE FOLLOWING U.S. PATENTS:

4,364,073	4,417,385	4,430,792	4,443,931	4,466,176	4,516,143	4,532,534	4,567,641
4,587,713	4,598,461	4,605,948	4,618,872	4,620,211	4,631,564	4,639,754	4,639,762
4,641,162	4,644,637	4,682,195	4,684,413	4,694,313	4,717,679	4,743,952	4,783,690
4,794,432	4,801,986	4,803,533	4,809,045	4,809,047	4,810,665	4,823,176	4,837,606
4,860,080	4,883,767	4,888,627	4,890,143	4,901,127	4,904,609	4,933,740	4,963,951
4,969,027							

CAUTION: These devices are sensitive to electrostatic discharge; follow proper IC Handling Procedures.

Electrical Specifications $T_C = +25^oC$, Unless Otherwise Specified

PARAMETERS	SYMBOL	TEST CONDITIONS	LIMITS HGTD10N40F1 HGTD10N40F1S MIN	MAX	HGTD10N50F1 HGTD10N50F1S MIN	MAX	UNITS
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 250\mu A$, $V_{GE} = 0V$	400	-	500	-	V
Gate Threshold Voltage	$V_{GE(TH)}$	$V_{GE} = V_{CE}$, $I_C = 1mA$	2.0	4.5	2.0	4.5	V
Zero Gate Voltage Collector Current	I_{CES}	$T_J = +150^oC$, $V_{CE} = 400V$	-	250	-	-	µA
		$T_J = +150^oC$, $V_{CE} = 500V$	-	-	-	250	µA
Gate-Emitter Leakage Current	I_{GES}	$V_{GE} = \pm 20V$, $V_{CE} = 0V$	-	100	-	100	nA
Collector-Emitter On-Voltage	$V_{CE(ON)}$	$T_J = +150^oC$, $I_C = 5A$, $V_{GE} = 10V$	-	2.5	-	2.5	V
		$T_J = +150^oC$, $I_C = 5A$, $V_{GE} = 15V$	-	2.2	-	2.2	V
		$T_J = +25^oC$, $I_C = 5A$, $V_{GE} = 10V$	-	2.5	-	2.5	V
		$T_J = +25^oC$, $I_C = 5A$, $V_{GE} = 15V$	-	2.2	-	2.2	V
Gate-Emitter Plateau Voltage	V_{GEP}	$I_C = 5A$, $V_{CE} = 10V$	5.3 (Typ)				V
On-State Gate Charge	$Q_{G(ON)}$	$I_C = 5A$, $V_{CE} = 10V$	13.4 (Typ)				nC
Turn-On Delay Time	$t_{D(ON)}$	Resistive Load, $I_C = 5A$, $V_{CE} = 400V$, $R_L = 80\Omega$, $T_J = +150^oC$, $V_{GE} = 10V$, $R_G = 25\Omega$	45 (Typ)				ns
Rise Time	t_{RI}		35 (Typ)				ns
Turn-Off Delay Time	$t_{D(OFF)}$		130 (Typ)				ns
Fall Time	t_{FI}		1400 (Typ)				ns
Turn-Off Energy Loss Per Cycle (Off Switching Dissipation = W_{OFF} x Frequency)	W_{OFF}		0.64 (Typ)				mJ
Turn-Off Delay Time	$t_{D(OFF)}$	Inductive Load (See Figure 11), $I_C = 5A$, $V_{CE(CLP)} = 400V$, $R_L = 80\Omega$, $L = 50\mu H$, $T_J = +150^oC$, $V_{GE} = 10V$, $R_G = 25\Omega$	-	375	-	375	ns
Fall Time	t_{FI}		-	1200	-	1200	ns
Turn-Off Energy Loss Per Cycle (Off Switching Dissipation = W_{OFF} x Frequency)	W_{OFF}		-	1.2	-	1.2	mJ
Thermal Resistance Junction-to-Case (IGBT)	$R_{\theta JC}$		-	1.67	-	1.67	$^oC/W$

Typical Performance Curves

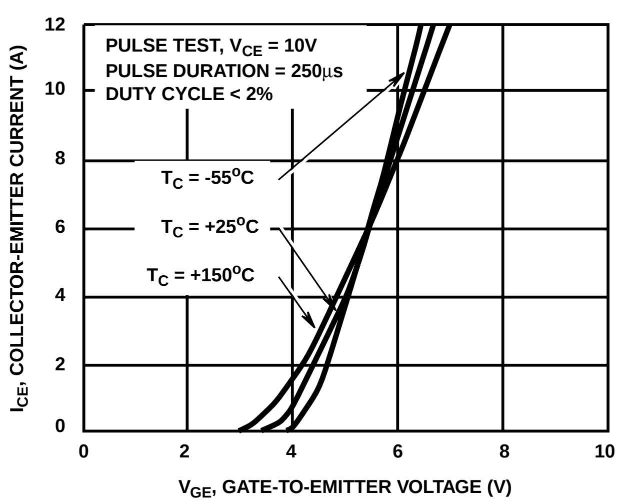


FIGURE 1. TYPICAL TRANSFER CHARACTERISTICS

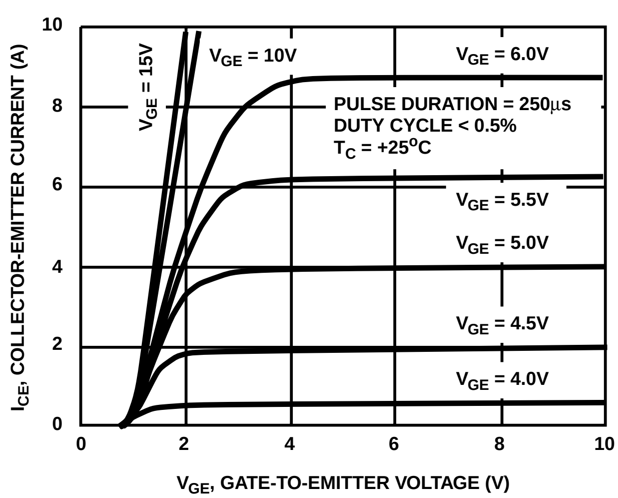


FIGURE 2. TYPICAL SATURATION CHARACTERISTICS

Typical Performance Curves (Continued)

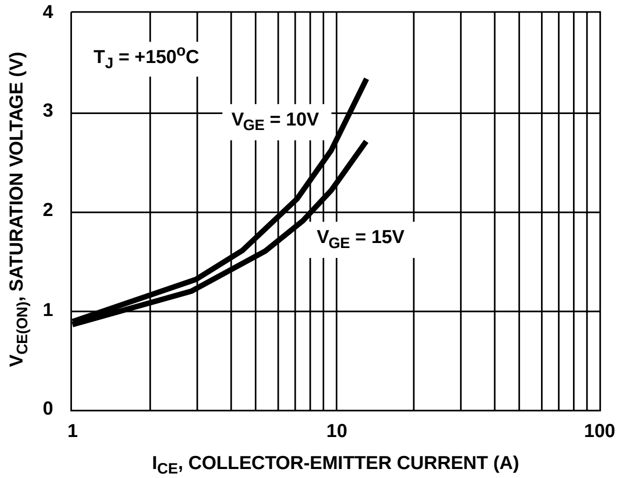


FIGURE 3. SATURATION VOLTAGE vs COLLECTOR-EMITTER CURRENT (TYPICAL)

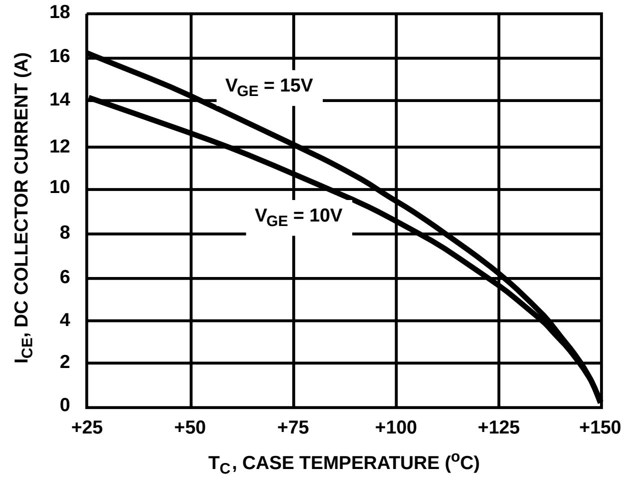


FIGURE 4. DC COLLECTOR CURRENT vs CASE TEMPERATURE

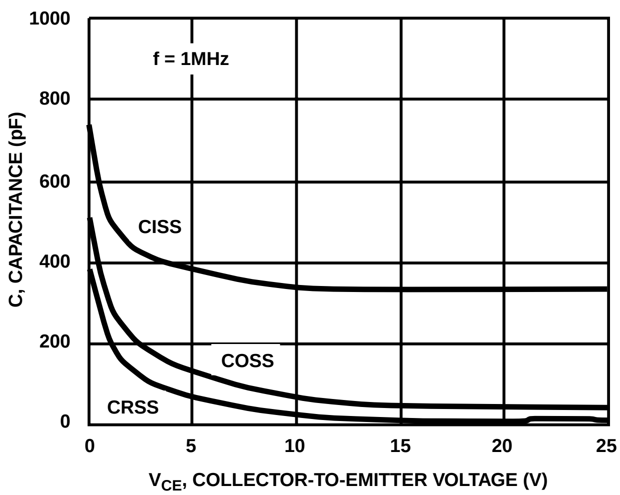


FIGURE 5. CAPACITANCE vs COLLECTOR-TO-EMITTER VOLTAGE (TYPICAL)

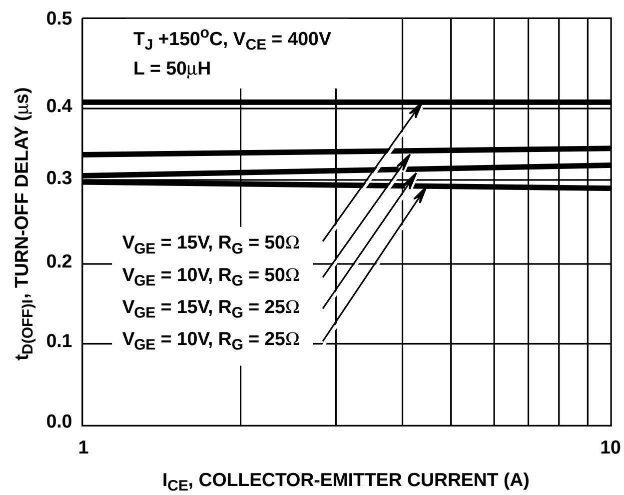


FIGURE 6. TURN-OFF DELAY vs COLLECTOR-TO-EMITTER CURRENT (TYPICAL)

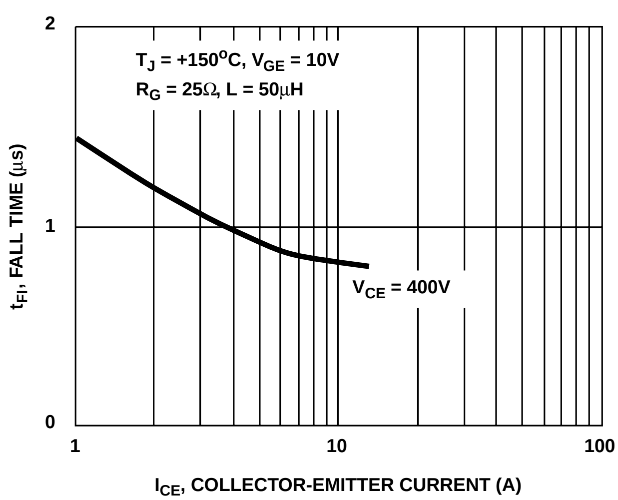


FIGURE 7. FALL TIME vs COLLECTOR-TO-EMITTER CURRENT (TYPICAL)

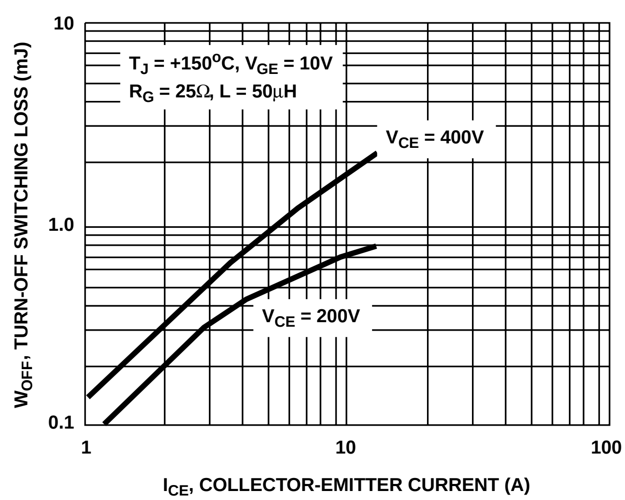


FIGURE 8. TURN-OFF SWITCHING LOSS vs COLLECTOR-EMITTER CURRENT (TYPICAL)

Typical Performance Curves (Continued)

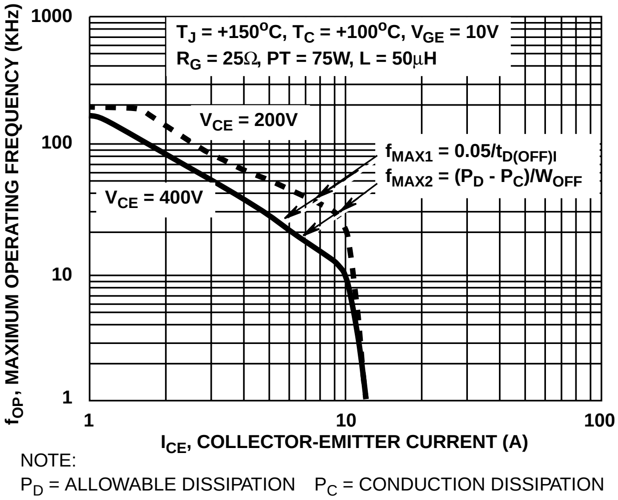


FIGURE 9. MAXIMUM OPERATING FREQUENCY vs COLLECTOR CURRENT AND VOLTAGE (TYPICAL)

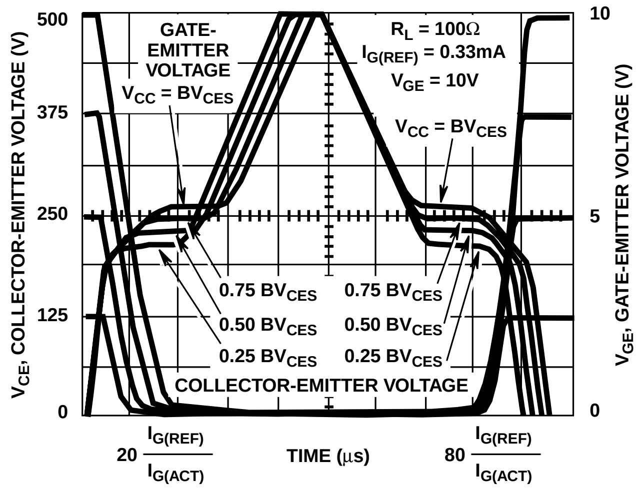


FIGURE 10. NORMALIZED SWITCHING WAVEFORMS AT CONSTANT GATE CURRENT

Test Circuit

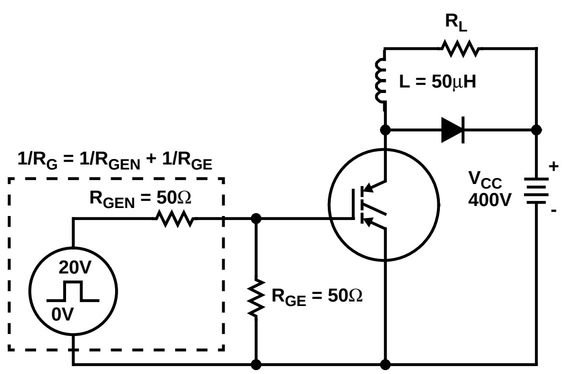


FIGURE 11. INDUCTIVE SWITCHING TEST CIRCUIT

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